

<b>Notice of References Cited</b>	Application/Control No. 10/632,089	Applicant(s)/Patent Under Reexamination TIRKKONEN ET AL.	
	Examiner Duc M. Nguyen	Art Unit 2685	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0128769 A1	07-2003	Kim et al.	375/265
*	B	US-2003/0060173 A1	03-2003	Lee et al.	455/103
*	C	US-2002/0114269 A1	08-2002	Onggosanusi et al.	370/208
*	D	US-2002/0062472 A1	05-2002	Medlock et al.	716/1
*	E	US-2003/0091098 A1	05-2003	Manninen et al.	375/133
*	F	US-6,925,131 B2	08-2005	Balakrishnan et al.	375/299
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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